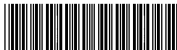


Search Notes**Application/Control No.**

10/657,442

Examiner

CHRISTIAN E. RENDÓN

**Applicant(s)/Patent under
Reexamination**

RANDALL ET AL.

Art Unit

3714

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR